LM57 Resistor-Programmable Temperature Switch and Analog Temperature Sensor



Literature Number: SNIS152C



Resistor-Programmable Temperature Switch and Analog Temperature Sensor

General Description

The LM57 is a precision, dual-output, temperature switch with integrated analog temperature sensor. The trip temperature (T_{TRIP}) is programmable by using two external 1% resistors. Using extremely small packaged resistors (0.5 mm x 1 mm), the LM57 can be programmed to any of 256 trip temperatures while consuming very little board space. The V_{TEMP} output delivers an analog output voltage which is proportional with a negative temperature coefficient (NTC) to the measured temperature.

Built-in temperature hysteresis (T_{HYST}) keeps the output stable in an environment of thermal oscillation. The digital temperature switch outputs will go active when the die temperature exceeds T_{TRIP} and will release when the temperature falls below a temperature equal to T_{TRIP} minus T_{HYST}. One of the digital outputs, T_{OVER}, is active-high with a push-pull structure. The other digital output, $\overline{T_{OVER}}$, is active-low with an opendrain structure.

Driving the TRIP-TEST input high will make the digital outputs active. A processor can read the logic level of the temperature switch outputs, confirming that they changed to their active state. This allows for in-situ verification that the comparator and output circuitry are functional after system assembly. When the TRIP-TEST pin is high, the trip-level reference voltage appears at the Vtemp pin. The system could then use this voltage to calibrate the sensor for even tighter accuracy. Tying $T_{\rm OVER}$ to TRIP-TEST will latch the output after it trips. It can be cleared by forcing TRIP-TEST low or powering off the LM57.

As it draws only 28 μ A max from its supply, it has very low self-heating, about 0.02°C in still air.

Applications

- Cell phones
- Wireless transceivers
- Digital cameras
- Personal digital assistants (PDA's)
- Battery management
- Automotive
- Disk drives
- Games
- Appliances

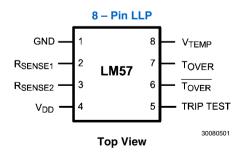
Features

- Trip temperature set by external resistors
- External resistor tolerance contributes zero error
- Push-pull and open-drain temperature switch outputs
- Wide operating temperature and trip-temperature range of -50°C to 150°C
- Very linear analog V_{TEMP} temperature sensor output
- Analog and digital outputs are short-circuit protected
- TRIP-TEST pin allows in-system testing
- Latching function for the digital outputs
- Very small 2.5 mm by 2.5 mm 8-Pin LLP package

Key Specifications

- Supply voltage
 Supply current
 Temperature switch accuracy
 ±1.5°C
 Analog (V_{TEMP}) Accuracy
 ±0.7°C
 Operating temperature
 - Hysteresis magnitude
 - 5°C, 10°C

Connection Diagram



Typical Application

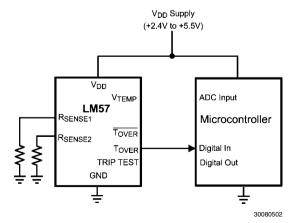
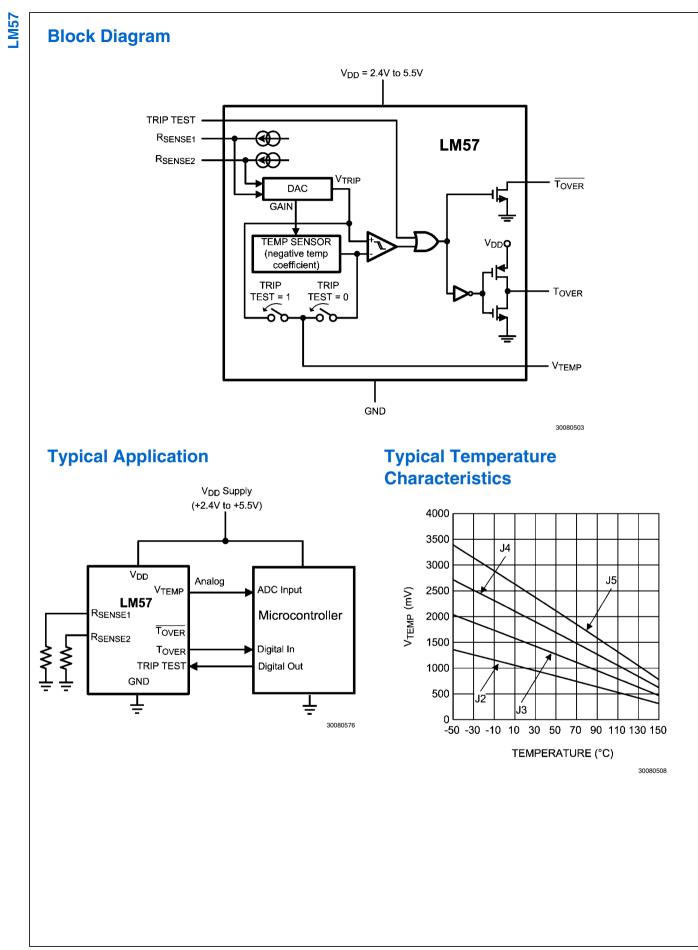


FIGURE 1. Over-Temperature Output to Microcontroller Digital Input



Ground Ground Ground Digital Input Digital Output	VDD VDD VDD VDD VDD VDD VDD VDD VDD VDD	Power Supply GroundTrip-Point Resistor Sense. One of two sense pins which selects the temperature at which T_{OVER} and $\overline{T_{OVER}}$ will go active.Trip-Point Resistor Sense. One of two sense pins which selects the temperature at which T_{OVER} and $\overline{T_{OVER}}$ will go active.Supply VoltageTRIP TEST pin. Active High input. If TRIP TEST = 0 (Default), then the V_{TEMP} output has the analo temperature sensor output voltage.If TRIP TEST = 1, then T_{OVER} and $\overline{T_{OVER}}$ outputs are asserted an $V_{TEMP} = V_{TRIP}$, the Temperature Trip Voltage.Tie this pin to ground if not used.Over Temperature Switch output Active Low, Open-drain (See Section 2.1 regarding required pul up resistor.)Asserted when the measured temperature exceeds the Trip Poi Temperature or if TRIP TEST = 1
2 Power Digital Input Digital		the temperature at which T_{OVER} and $\overline{T_{OVER}}$ will go active.Trip-Point Resistor Sense. One of two sense pins which selects the temperature at which T_{OVER} and $\overline{T_{OVER}}$ will go active.Supply VoltageTRIP TEST pin. Active High input. If TRIP TEST = 0 (Default), then the V_{TEMP} output has the analo temperature sensor output voltage.
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Digital Input Digital		TRIP TEST pin. Active High input.If TRIP TEST = 0 (Default), then the V_{TEMP} output has the analotemperature sensor output voltage.If TRIP TEST = 1, then T_{OVER} and $\overline{T_{OVER}}$ outputs are asserted ar $V_{TEMP} = V_{TRIP}$, the Temperature Trip Voltage.Tie this pin to ground if not used.Over Temperature Switch outputActive Low, Open-drain (See Section 2.1 regarding required pulup resistor.)Asserted when the measured temperature exceeds the Trip Poi
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-		Active Low, Open-drain (See Section 2.1 regarding required pu up resistor.) Asserted when the measured temperature exceeds the Trip Poi
		This pin may be left open if not used.
Digital Output		Over Temperature Switch output Active High, Push-Pull Asserted when the measured temperature exceeds the Trip Poi Temperature or if TRIP TEST = 1 This pin may be left open if not used.
Analog Output		V_{TEMP} Analog Voltage Output If TRIP TEST = 0, then $V_{\text{TEMP}} = V_{\text{TS}}$, Temperature Sensor Outp Voltage If TRIP TEST = 1, then $V_{\text{TEMP}} = V_{\text{TRIP}}$, Temperature Trip Voltag This pin may be left open if not used.
ermal Pad (LLP	package only)	Connect to GND
	Analog Output	Analog Output

Ordering Information

Package	Part Number	Package Marking	Transport Media	NSC Drawing
	LM57BISD-5	57B5	1k Units Tape and Reel	SDA08B
	LM57BISDX-5	57B5	4.5k Units Tape and Reel	SDA08B
	LM57BISD-10	57B9	1k Units Tape and Reel	SDA08B
8-Pin LLP	LM57BISDX-10	57B9	4.5k Units Tape and Reel	SDA08B
0-PIII LLP	LM57CISD-5	57C5	1k Units Tape and Reel	SDA08B
	LM57CISDX-5	57C5	4.5k Units Tape and Reel	SDA08B
	LM57CISD-10	57C9	1k Units Tape and Reel	SDA08B
	LM57CISDX-10	57C9	4.5k Units Tape and Reel	SDA08B

Note:

The "-5" suffix is for 5°C hysteresis

The "-10" suffix is for 10°C hysteresis

Contact National Semiconductor Corporation for high temperature die (above 150°C).

	-
Supply Voltage	-0.3V to 6V
Voltage at T _{OVER}	-0.3V to 6V
Voltage at T _{OVER} , V _{TEMP} , TRIP-TEST,	
R _{SENSE1} , and R _{SENSE2}	–0.3V to (V _{DD} + 0.3V)
Current at any pin	5 mA
Storage Temperature Range	–65°C to 150°C
ESD Susceptibility (Note 2)	
Human Body Model	5500V
Machine Model	450V
Charged Device Model	1250V

Operating Ratings (Note 1)

Specified Temperature Range Supply Voltage Range

-50°C to 150°C +2.4 V to 5.5V

Charged Device Model 1250V Soldering process must comply with National's Reflow

Temperature Profile specifications. Refer to www.national.com/ packaging. (Note 3)

Accuracy Characteristics There are four gains corresponding to each of the four Temperature Trip Point Ranges.

J2 is the sensor gain used for Temperature Trip Point -41°C to 51.8°C.

J3 is for Trip Points 52°C to 97°C.

J4 for 97°C to 119°C.

J5 for 119°C to 150°C.

Trip Point Accuracy

Parameter		Condition	LM57B	LM57C	Units (M ax)	
	J2	$T_A = -41^{\circ}C$ to $52^{\circ}C$	$V_{DD} = 2.4 V \text{ to } 5.5 V$	±1.5	±2.3	°C
Trip Point Accuracy (Includes 1% set-resistor	J3	$T_A = 52^{\circ}C \text{ to } 97^{\circ}C$	$V_{DD} = 2.4V$ to 5.5V	±1.5	±2.3	°C
tolerance) (<i>Note 9</i>)	J4	$T_A = 97^{\circ}C$ to $119^{\circ}C$	$V_{DD} = 2.4V$ to 5.5V	±1.5	±2.3	°C
	J5	T _A = 119°C to 150°C	$V_{DD} = 2.4V$ to 5.5V	±1.5	±2.3	°C

V_{TEMP} Analog Temperature Sensor Output Accuracy

These limits do not include DC load regulation. These stated accuracy limits are with reference to the values in the LM57 V_{TEMP} Temperature-to-Voltage Table.

Parameter		Conditi	LM57B	LM57C	Units (Max)		
	J2	$T_A = -50^{\circ}C$ to $150^{\circ}C$	V _{DD} = 2.4V to 5.5V	±0.95	±1.3	°C	
	J3	$T_A = -50^{\circ}C$ to $150^{\circ}C$	$V_{DD} = 2.4V$ to 5.5V	±0.8	±1.3	°C	
V _{TEMP} Accuracy	J4	$T_A = 20^{\circ}C \text{ to } 50^{\circ}C$	V _{DD} = 2.4V to 5.5V	±0.7	±1.3		
(These stated accuracy limits are		$T_A = 0^{\circ}C$ to $150^{\circ}C$	V _{DD} = 2.7V to 5.5V	±0.7	±1.3	°C	
with reference to the values in the		$T_A = -50^{\circ}C$ to $0^{\circ}C$	$V_{DD} = 3.1 V \text{ to } 5.5 V$	±0.8	±1.3		
LM57 Temperature-to-Voltage	J5	$T_A = 60^{\circ}C \text{ to } 150^{\circ}C$	$V_{DD} = 2.4V$ to 5.5V	±0.7	±1.3		
Table) (<i>Note 9</i>)		$T_A = 20^{\circ}C \text{ to } 50^{\circ}C$	V _{DD} = 2.9V to 5.5V	±0.7	±1.3	°C	
		$T_A = 0^{\circ}C \text{ to } 150^{\circ}C$	V _{DD} = 3.2V to 5.5V	±0.7	±1.3	U	
		$T_A = -50^{\circ}C$ to $0^{\circ}C$	V _{DD} = 4.0V to 5.5V	±0.8	±1.3		

Electrical Characteristics

Unless otherwise noted, these specifications apply for V_{DD} = 2.4V to 5.5V. **Boldface** limits apply for $T_A = T_J = T_{MIN}$ to T_{MAX} ; All other limits apply to $T_A = T_J = +25^{\circ}C$, unless otherwise noted.

Symbol	Parameter	Conditions	Min (<i>Note 5</i>)	Typ (<i>Note 4</i>)	Max (<i>Note 5</i>)	Units
empera	ture Sensor		(1010-0)	(11010 4)	(11010-0)	
		J2 –41°C to 52°C		-5.166		
		J3 52°C to 97°C		-7.752		
	V _{TEMP} Sensor Gain	J4 97°C to 119°C		-10.339		mV/°0
		J5 119°C to 150°C		-12.924		
	Line Degulation DC: Cumhute			0.18		mV
	Line Regulation DC: Supply-to- V _{TEMP} (<i>Note 6</i>)	V _{DD} = 2.4V to 5.5V, Gain = J4, Temp = 90°C		58		μV/V
				-84		dB
		Source \leq 240 µA, (V _{DD} - V _{TEMP}) \geq 200 mV			-1	
	Load Regulation: V _{TEMP} Output	Sink ≤ 300 μA, V _{TEMP} ≥ 360 mV			1	mV
	(Note 10)	Source or Sink = 100 µA		1		Ω
	Load Capacitance: V _{TEMP} Output	No output series resistor required			4400	-
	(Note 11)	(See section 5.2)			1100	pF
	Supply Current: Quiescent			24	28	μA
8	(Note 7)			24	20	μΛ
	ST Input					
ін	Logic "1" Threshold Voltage		V _{DD} - 0.5			V
IL	Logic "0" Threshold Voltage				0.5	V
1	Logic "1" Input Current			1.4	3	μA
-	Logic "0" Input Leakage Current (Note 8)			0.001	1	μA
_{OVER} (Pi	ush-Pull, Active-High) Output					
,		Source ≤ 600 µA	V _{DD} - 0.2			
он	Logic "1" Push-Pull Output Voltage	Source ≤ 1.2 mA	V _{DD} - 0.45			V
		Sink ≤ 600 µA			0.2	
OL	Logic "0" Output Voltage	Sink ≤ 1.2 mA			0.45	V
	pen-Drain, Active-Low) Output					
		Sink ≤ 600 μA			0.2	
OL	Logic "0" Output Voltage	Sink ≤1.2 mA			0.45	V
ЭН	Logic "1" Output Leakage Current (<i>Note 8</i>)	Temperature = 30°C		0.001	1	μA
lysteres						
.,		5°C hysteresis option	4.7	5	5.4	°C
HYST	Hysteresis Temperature	10°C hysteresis option	9.6	10	10.6	°C
iming				-		
-	Time from power on to Digital			10		
EN	Output Enabled (<i>Note 11</i>)			1.0	2.9	ms
	Time from Power on to Analog					
/TEMP	Temperature (V _{TEMP}) valid (<i>Note 11</i>)			1.0	2.9	ms

Note 1: Absolute Maximum Ratings indicate limits beyond which damage may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not guaranteed. For guaranteed specifications and test conditions, see the Electrical Characteristics.

Note 2: The Human Body Model (HBM) is a 100 pF capacitor charged to the specified voltage then discharged through a 1.5 kΩ resistor into each pin. The Machine Model (MM) is a 200 pF capacitor charged to the specified voltage then discharged directly into each pin. The Charged Device Model (CDM) is a specified circuit characterizing an ESD event that occurs when a device acquires charge through some triboelectric (frictional) or electrostatic induction processes and then abruptly touches a grounded object or surface.

Note 3: Reflow temperature profiles are different for lead-free and non-lead-free packages.

Note 4: Typicals are at $T_J = T_A = 25^{\circ}C$ and represent most likely parametric norm.

Note 5: Limits are guaranteed to National's AOQL (Average Outgoing Quality Level).

Note 6: Line regulation (DC) is calculated by subtracting the output voltage at the highest supply voltage from the output voltage at the lowest supply voltage. The typical DC line regulation specification does not include the output voltage shift discussed in Section 5.3.

Note 7: Supply Current refers to the quiescent current of the LM57 only and does not include any load current

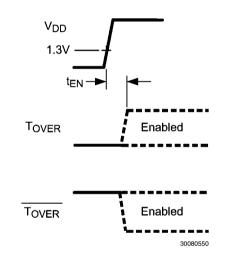
Note 8: This current is leakage current only and is therefore highest at high temperatures. Prototype test indicate that the leakage is well below 1 µA over the full temperature range. This 1 µA specification reflects the limitations of measuring leakage at room temperature. For this reason only, the leakage current is not guaranteed at a lower value.

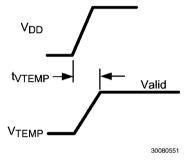
Note 9: Accuracy is defined as the error between the measured and reference output voltages, tabulated in the Conversion Table at the specified conditions of supply gain setting, voltage, and temperature (expressed in °C). Accuracy limits include line regulation within the specified conditions. Accuracy limits do not include load regulation; they assume no DC load.

Note 10: Source currents are flowing out of the LM57. Sink currents are flowing into the LM57. Load Regulation is calculated by measuring Vtemp at 0 µA and subtracting the value with the conditions specified.

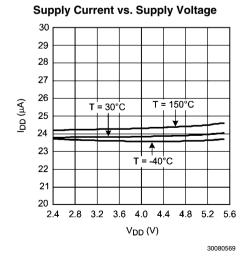
Note 11: Guaranteed by design and characterization.

Definitions of t_{EN} and $t_{V_{TEMP}}$

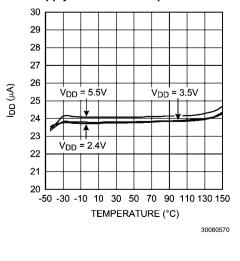


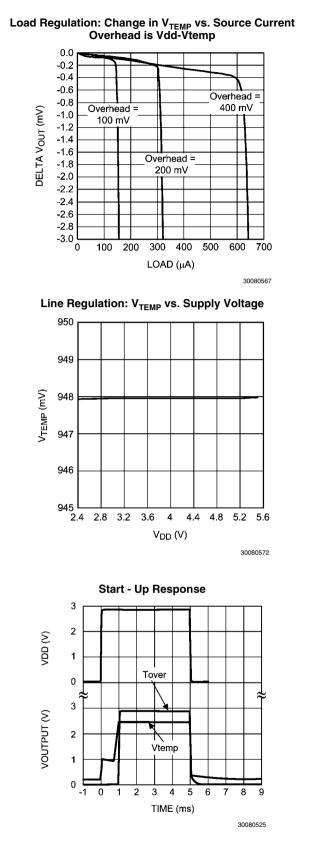


Typical Performance Characteristics

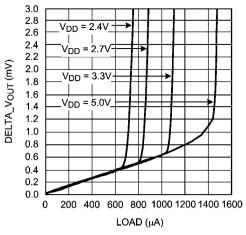


Supply Current vs. Temperature



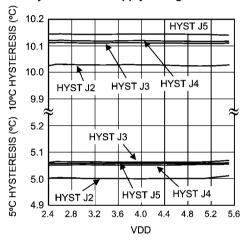


Load Regulation: Change in V_{TEMP} vs. Sink Current

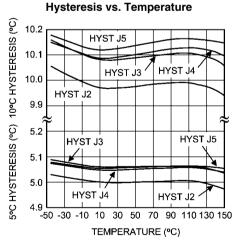


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Line Regulation: Hysteresis vs. Supply Voltage 30°C



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Application Information

1.0 RESISTOR PROGRAMMING

Trip Point (°C) vs. Set-Resistor Values (Ω**)**

	R _{SENSE2}													
			J	2		J3			J	4		J5		
	2	976k	825k	698k	590k	499k	412k	340k	280k	226k	178k	140k	105k	75k
	976k	-40.7	-16.3	7.3	30.4	52.7	67.8	82.7	97.5	108.6	119.6	128.5	137.3	146.1
	825k	-39.1	-14.8	8.8	31.8	53.7	68.7	83.7	98.2	109.3	120.2	129.0	137.8	146.6
	698k	-37.6	-13.3	10.2	33.2	54.6	69.6	84.6	98.9	110.0	120.7	129.6	138.4	147.2
	590k	-36.0	-11.8	11.7	34.7	55.6	70.6	85.5	99.6	110.7	121.3	130.1	138.9	147.7
	499k	-34.5	-10.3	13.1	36.1	56.5	71.5	86.5	100.3	111.4	121.8	130.7	139.5	148.3
	412k	-32.9	-8.8	14.6	37.5	57.4	72.5	87.4	100.9	112.1	122.4	131.2	140.0	148.8
	340k	-31.4	-7.3	16.1	39.0	58.4	73.4	88.3	101.6	112.8	122.9	131.8	140.6	149.3
Б	280k	-29.9	-5.8	17.5	40.4	59.3	74.3	89.3	102.3	113.5	123.5	132.3	141.1	149.9
R _{SENSE1}	226k	-28.3	-4.3	18.9	41.8	60.3	75.3	90.2	103.0	114.2	124.0	132.9	141.7	
	178k	-26.8	-2.9	20.4	43.2	61.2	76.2	91.1	103.7	114.9	124.6	133.4	142.2	
	140k	-25.3	-1.4	21.8	44.7	62.1	77.1	92.1	104.4	115.6	125.2	134.0	142.8	
	105k	-23.8	0.0	23.2	46.1	63.1	78.1	93.0	105.1	116.3	125.7	134.5	143.3	
	75k	-22.3	1.5	24.7	47.5	64.0	79.0	93.9	105.8	117.0	126.3	135.1	143.9	
	46.4k	-20.8	3.0	26.1	48.9	65.0	79.9	94.8	106.5	117.6	126.8	135.6	144.4	
	22.6k	-19.3	4.4	27.5	50.3	65.9	80.9	95.8	107.2	118.3	127.4	136.2	145.0	
	0.01k	-17.8	5.9	28.9	51.8	66.8	81.8	96.7	107.9	119.0	127.9	136.7	145.5	

V_{TEMP} (mV) at the Trip Point vs. Set-Resistor Value ($\Omega)$

						R	SENSE2							
			J	2	_	J3			J4		J5			
		976k	825k	698k	590k	499k	412k	340k	280k	226k	178k	140k	105k	75k
	976k	1306.2	1183.8	1064.0	945.6	1243.7	1125.3	1006.8	1185.3	1066.0	1184.0	1064.6	944.8	825.0
	825k	1298.5	1176.2	1056.6	938.2	1236.3	1117.9	999.3	1177.8	1058.5	1176.6	1057.1	937.3	817.5
	698k	1290.7	1168.7	1049.1	930.8	1228.9	1110.5	991.9	1170.4	1051.0	1169.1	1049.6	929.8	810.1
	590k	1283.0	1161.2	1041.7	923.4	1221.5	1103.1	984.5	1163.0	1043.6	1161.6	1042.1	922.3	802.7
	499k	1275.3	1153.6	1034.3	916.0	1214.1	1095.7	977.1	1155.5	1036.1	1154.2	1034.6	914.8	795.2
	412k	1267.6	1146.1	1026.8	908.6	1206.7	1088.3	969.7	1148.1	1028.6	1146.7	1027.2	907.3	787.8
	340k	1259.9	1138.6	1019.4	901.2	1199.3	1080.9	962.2	1140.7	1021.1	1139.2	1019.7	899.8	780.3
в	280k	1252.2	1131.0	1012.0	893.8	1191.9	1073.5	954.8	1133.2	1013.6	1131.7	1012.2	892.3	772.9
R _{SENSE1}	226k	1244.6	1123.5	1004.6	886.4	1184.5	1066.0	947.3	1125.8	1006.1	1124.3	1004.7	884.8	
	178k	1237.0	1116.0	997.3	879.0	1177.1	1058.6	939.9	1118.3	998.7	1116.8	997.2	877.3	
	140k	1229.4	1108.6	989.9	871.6	1169.7	1051.2	932.5	1110.9	991.2	1109.3	989.7	869.8	
	105k	1221.8	1101.2	982.5	864.2	1162.3	1043.8	925.0	1103.5	983.7	1101.8	982.2	862.3	
	75k	1214.1	1093.7	975.2	856.8	1154.9	1036.4	917.6	1096.0	976.2	1094.4	974.8	854.8	
	46.4k	1206.5	1086.3	967.8	849.4	1147.5	1029.0	910.2	1088.6	968.7	1086.9	967.3	847.3	
	22.6k	1198.9	1078.9	960.4	842.0	1140.1	1021.6	902.7	1081.2	961.2	1079.4	959.8	839.8	
	0.01k	1191.3	1071.4	953.1	834.6	1132.7	1014.2	895.3	1073.7	953.8	1072.0	952.3	832.3	

1.1 Selection of R_{SET} Resistors To set the trip point:

(1) Locate the desired trip temperature on the Trip Point Table.

(2) Identify the corresponding R_{SENSE2} value by following the column up to the resistor value.

(3) Identify the corresponding $\rm R_{\rm SENSE1}$ value by following the row leftwards to the resistor value.

(4) Use only the EIA E96 standard resistor values from the list.

(5) Use only the resistor with 1% tolerance and a temperature coefficient of 100ppm (or better). These restrictions are nec-

2.0 LIVIS7 V _{TEMP}	V _{TEMP} (mV)							
Temperature (°C)	J2	J3	J4	J5				
-50	1353	2029	2705	3381				
-49	1348	2021	2695	3369				
-48	1343	2014	2685	3357				
-47	1338	2006	2675	3344				
-46	1333	1999	2665	3332				
-45	1328	1992	2655	3319				
-44	1323	1984	2646	3307				
-43	1318	1977	2636	3294				
-42	1313	1969	2626	3282				
-41	1308	1962	2616	3269				
-40	1303	1954	2606	3257				
-39	1298	1947	2596	3244				
-38	1293	1939	2586	3232				
-37	1288	1932	2576	3219				
-36	1283	1924	2566	3207				
-35	1278	1917	2556	3194				
-34	1273	1909	2546	3182				
-33	1268	1902	2536	3169				
-32	1263	1894	2526	3157				
-31	1258	1887	2516	3144				
-30	1253	1879	2506	3132				
-29	1248	1872	2495	3119				
-28	1243	1864	2485	3107				
-27	1238	1857	2475	3094				
-26	1233	1849	2465	3082				
-25	1228	1841	2455	3069				
-24	1223	1834	2445	3056				
-23	1218	1826	2435	3044				
-22	1213	1819	2425	3031				
-21	1208	1811	2415	3019				
-20	1203	1804	2405	3006				
-19	1198	1796	2395	2993				
-18	1193	1789	2385	2981				
-17	1188	1781	2375	2968				
-16	1182	1773	2365	2956				
-15	1177	1766	2354	2943				
-14	1172	1758	2344	2930				

essary to stay at the selected setting, and not to slip into an adjacent setting.

(6) This is consistent with using resistors from the Thick Film Chip Resistors CRCW0402 family. These are available with very small dimensions of L = 1.0mm, W = 0.5mm, H = 0.35mm.

(7) Note that the resistor tolerance does not diminish the accuracy of the trip point. See patent #6,924,758.

		V _{TEMF}	, (mV)	
Temperature (°C)	J2	J3	J4	J5
-13	1167	1751	2334	2918
-12	1162	1743	2324	2905
-11	1157	1735	2314	2892
-10	1152	1728	2304	2880
-9	1147	1720	2294	2867
-8	1142	1713	2284	2854
-7	1137	1705	2273	2842
-6	1132	1697	2263	2829
-5	1127	1690	2253	2816
-4	1122	1682	2243	2803
-3	1117	1675	2233	2791
-2	1112	1667	2223	2778
-1	1106	1659	2212	2765
0	1101	1652	2202	2753
1	1096	1644	2192	2740
2	1091	1636	2182	2727
3	1086	1629	2172	2714
4	1081	1621	2161	2702
5	1076	1613	2151	2689
6	1071	1606	2141	2676
7	1066	1598	2131	2663
8	1061	1590	2121	2650
9	1055	1583	2110	2638
10	1050	1575	2100	2625
11	1045	1567	2090	2612
12	1040	1560	2080	2599
13	1035	1552	2069	2586
14	1030	1544	2059	2574
15	1025	1537	2049	2561
16	1020	1529	2039	2548
17	1015	1521	2028	2535
18	1009	1514	2018	2522
19	1004	1506	2008	2509
20	999	1498	1997	2497
21	994	1490	1987	2484
22	989	1483	1977	2471
23	984	1475	1967	2458

	V _{TEMP} (mV)						
Temperature (°C)	J2	J3	J4	J5			
24	979	1467	1956	2445			
25	973	1460	1946	2432			
26	968	1452	1936	2419			
27	963	1444	1925	2406			
28	958	1436	1915	2394			
29	953	1429	1905	2381			
30	948	1421	1894	2368			
31	942	1413	1884	2355			
32	937	1405	1874	2342			
33	932	1398	1863	2329			
34	927	1390	1853	2316			
35	922	1382	1843	2303.0			
36	917	1374	1832	2290			
37	911	1367	1822	2277			
38	906	1359	1811	2264			
39	901	1351	1801	2251			
40	896	1343	1791	2238			
41	891	1335	1780	2225			
42	885	1328	1770	2212			
43	880	1320	1759	2199			
44	875	1312	1749	2186			
45	870	1304	1739	2173			
46	865	1296	1728	2160			
47	859	1289	1718	2147			
48	854	1281	1707	2134			
49	849	1273	1697	2121			
50	844	1265	1687	2108			
51	839	1257	1676	2095			
52	833	1249	1666	2082			
53	828	1242	1655	2069			
54	823	1234	1645	2056			
55	818	1226	1634	2043			
56	812	1218	1624	2030			
57	807	1210	1613	2016			
58	802	1202	1603	2003			
59	797	1194	1592	1990			
60	791	1187	1582	1977			
61	786	1179	1571	1964			
62	781	1171	1561	1951			
63	776	1163	1550	1938			
64	770	1155	1540	1925			
65	765	1147	1529	1911			
66	760	1139	1519	1898			
67	755	1131	1508	1885			
68	749	1124	1498	1872			
69	744	1116	1487	1859			
70	739	1108	1477	1846			
71	734	1100	1466	1833			

	V _{TEMP} (mV)			
Temperature (°C)	J2	J3	J4	J5
72	728	1092	1456	1819
73	723	1084	1445	1806
74	718	1076	1435	1793
75	713	1068	1424	1780
76	707	1060	1413	1767
77	702	1052	1403	1753
78	697	1044	1392	1740
79	691	1036	1382	1727
80	686	1028	1371	1714
81	681	1021	1360	1700
82	675	1013	1350	1687
83	670	1005	1339	1674
84	665	997	1329	1661
85	660	989	1318	1647
86	654	981	1307	1634
87	649	973	1297	1621
88	644	965	1286	1607
89	638	957	1276	1594
90	633	949	12/6	1581
91	628	941	1254	1568
92	622	933	1234	1554
92	617	935	1244	1541
93	612	925	1233	1528
94 95		909	1222	1520
95 96	606 601	909	1212	1501
90 97				
-	596	893	1190 1180	1488
98	590	885		1474
99	585	877	1169	1461
100	580	869	1158	1448
101	574	861	1148	1434
102	569	853	1137	1421
103	564	845	1126	1407
104	558	837	1115	1394
105	553	829	1105	1381
106	548	821	1094	1367
107	542	813	1083	1354
108	537	805	1073	1340
109	531	797	1062	1327
110	526	788	1051	1314
111	521	780	1040	1300
112	515	772	1030	1287
113	510	764	1019	1273
114	505	756	1008	1260
115	499	748	997	1246
116	494	740	986	1233
117	488	732	976	1219
118	483	724	965	1206
119	478	716	954	1192

	V _{TEMP} (mV)				
Temperature (°C)	J2	J3	J4	J5	
120	472	708	943	1179	
121	467	700	933	1165	
122	461	692	922	1152	
123	456	683	911	1138	
124	451	675	900	1125	
125	445	667	889	1111	
126	440	659	878	1098	
127	434	651	868	1084	
128	429	643	857	1071	
129	424	635	846	1057	
130	418	627	835	1044	
131	413	618	824	1030	
132	407	610	813	1017	
133	402	602	803	1003	
134	396	594	792	989	
135	391	586	781	976	
136	386	578	770	962	

	V _{TEMP} (mV)			
Temperature (°C)	J2	J3	J4	J5
137	380	570	759	949
138	375	561	748	935
139	369	553	737	921
140	364	545	726	908
141	358	537	716	894
142	353	529	705	881
143	347	520	694	867
144	342	512	683	853
145	336	504	672	840
146	331	496	661	826
147	326	488	650	812
148	320	480	639	799
149	315	471	628	785
150	309	463	617	771

Note: The Rset resistors select a trip point and a corresponding Vtemp gain (J2, J3, J4, or J5). The trip point range associated with a given gain is shown in bold on this table. The Vtemp gain is selected by the Rset resistors. Vtemp is valid over the entire temperature range.

2.1 LM57 V_{TEMP} Voltage -To-Temperature Equations

Trip-Point Region	LM57 Trip Point Range	V _{TEMP} (mV) Equations T(°C)
J2	–41°C to 52°C	$V_{\text{TEMP}} = 947.6 - 5.166(T-30) - 0.00129(T-30)^2$
J3	52°C to 97°C	V _{TEMP} = 1420.9 - 7.752(T-30) - 0.00191(T-30) ²
J4	97°C to 119°C	V _{TEMP} = 1894.3 – 10.339(T-30) - 0.00253(T-30) ²
J5	119°C to 150°C	V _{TEMP} = 2367.7 -12.924(T-30) - 0.00316(T-30) ²

3.0 T_{OVER} AND T_{OVER} DIGITAL OUTPUTS

The T_{OVER} Active High, Push-Pull Output and the $\overline{T_{OVER}}$ Active Low, Open-Drain Output both assert at the same time whenever the Die Temperature reaches the Trip Point. They also assert simultaneously whenever the TRIP TEST pin is set high. Both outputs de-assert when the die temperature goes below the (Temperature Trip Point) - (Hysteresis). These two types of digital outputs enable the user the flexibility to choose the type of output that is most suitable for his design.

Either the T_{OVER} or the $\overline{T_{\text{OVER}}}$ Digital Output pins can be left open if not used.

The $\overline{T_{OVER}}$ Active Low, Open-Drain Digital Output, if used, requires a pull-up resistor between this pin and V_{DD}.

3.1T_{OVER} and $\overline{T_{OVER}}$ Noise Immunity

The LM57 has some noise immunity to a premature trigger due to noise on the power supply. With the die temperature at 1°C below the trip point, there are no premature triggers for a square wave injected into the power supply with a magnitude of 100 mV_{PP} over a frequency range of 100 Hz to 2 MHz. Above the frequency a premature trigger may occur.

With the die temperature at 2°C below the trip point, and a magnitude of 200 mV_{PP}, there are no premature triggers from 100 Hz to 300 kHz. Above that frequency a premature trigger may occur.

Therefore if the supply line is noisy, it is recommended that a local supply decoupling cap be used to reduce that noise.

4.0 TRIP TEST DIGITAL INPUT

The TRIP TEST pin provides a means to test the digital outputs by causing them to assert, regardless of temperature.

In addition, when the TRIP TEST pin is pulled high the V_{TEMP} pin will be at the V_{TRIP} voltage.

5.0 V_{TEMP} ANALOG TEMPERATURE SENSOR OUTPUT

The V_{TEMP} push-pull output provides the ability to sink and source significant current. This is beneficial when, for example, driving dynamic loads like an input stage on an analogto-digital converter (ADC). In these applications the source current is required to quickly charge the input capacitor of the ADC. See the Applications Circuits section for more discussion of this topic. The LM57 is ideal for this and other applications which require strong source or sink current.

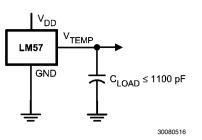
5.1 V_{TEMP} Noise Considerations

A load capacitor on V_{TEMP} can help to filter noise.

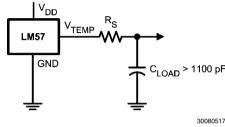
For noisy environments, a 100nF supply decoupling cap placed closed across $\rm V_{\rm DD}$ and GND pins of LM57 is recommended.

5.2 V_{TEMP} Capacitive Loads

The V_{TEMP} Output handles capacitive loading well. In an extremely noisy environment, or when driving a switched sampling input on an ADC, it may be necessary to add some filtering to minimize noise coupling. Without any precautions, the V_{TEMP} can drive a capacitive load less than or equal to 1100 pF as shown in *Figure 2*. For capacitive loads greater than 1100 pF, a series resistor is required on the output, as shown in *Figure 3*, to maintain stable conditions.







CLOAD	Minimum R _s	
1.1 nF to 99 nF	3 kΩ	
100 nF to 999 nF	1.5 kΩ	
1 µF	750 Ω	

FIGURE 3. LM57 with Series Resistor for Capacitive Loading greater than 1100 pF.

5.3 V_{TEMP} Voltage Shift

The LM57 is very linear over temperature and supply voltage range. Due to the intrinsic behavior of an NMOS/PMOS rail-to-rail buffer, a slight shift in the output can occur when the supply voltage is ramped over the operating range of the device. The location of the shift is determined by the relative levels of V_{DD} and V_{TEMP}. The shift typically occurs when V_{DD} - V_{TEMP} = 1.0V.

This slight shift (a few millivolts) takes place over a wide change (approximately 200 mV) in V_{DD} or V_{TEMP}. Since the shift takes place over a wide temperature change of 5°C to 20°C, V_{TEMP} is always monotonic. The accuracy specifications in the Electrical Characteristics table already includes this possible shift.

6.0 MOUNTING AND TEMPERATURE CONDUCTIVITY

The LM57 can be applied easily in the same way as other integrated-circuit temperature sensors. It can be glued or cemented to a surface.

To ensure good temperature conductivity, the backside of the LM57 die is directly attached to the exposed pad. The temperatures of the lands and traces to the other leads of the LM57 will also affect the temperature reading.

Alternatively, the LM57 can be mounted inside a sealed-end metal tube, and can then be dipped into a bath or screwed into a threaded hole in a tank. As with any IC, the LM57 and accompanying wiring and circuits must be kept insulated and dry, to avoid leakage and corrosion. This is especially true if the circuit may operate at cold temperatures where condensation can occur. If moisture creates a short circuit from the V_{TEMP} output to ground or $V_{\text{DD}},$ the V_{TEMP} output from the LM57 will not be correct. Printed-circuit coatings are often used to ensure that moisture cannot corrode the leads or circuit traces.

The LM57's junction temperature is the actual temperature being measured. The thermal resistance junction-to-ambient (θ_{JA}) is the parameter (from Figure 4) used to calculate the rise of a device junction temperature due to its power dissipation. The equation used to calculate the rise in the LM57's die temperature is

$$\mathsf{T}_{\mathsf{J}} = \mathsf{T}_{\mathsf{A}} + \boldsymbol{\theta}_{\mathsf{J}\mathsf{A}} \left[\left(\mathsf{V}_{\mathsf{D}\mathsf{D}} \mathsf{I}_{\mathsf{Q}} \right) + \left(\mathsf{V}_{\mathsf{D}\mathsf{D}} - \mathsf{V}_{\mathsf{T}\mathsf{E}\mathsf{M}\mathsf{P}} \right) \; \mathsf{I}_{\mathsf{L}} \right]$$

where T_A is the ambient temperature, I_Q is the quiescent current, I_L is the load current on Vtemp.

For example, in an application where $T_A = 30$ °C, $V_{DD} = 5.5$ V, $I_{DD} = 28 \ \mu$ A, J5 gain, $V_{TEMP} = 2368 \ m$ W, and $I_L = 0 \ \mu$ A, the total temperature rise would be $[152^{\circ}C/W^{+}5.5V^{+}28\mu$ A] = 0.023°C. To minimize self-heating, the load current on Vtemp should be minimized.

Device Number	Thermal Resistance (θ _{JA})	NS Package Number	
LM57	152° C/W	SDA08B	

FIGURE 4. LM57 Thermal Resistance

7.0 Rset TABLE

The LM57 uses the voltage at the two Rsense pins to set the trip point for the temperature switch. It is possible to drive the

two Rsense pins with a voltage equal to the value generated by the resistor and the internal current-source and have the same switch point. Thus one can use an external DAC to drive each Rsense pin, allowing for the temperature trip point to be set dynamically by the system processor. The table shows the Rset value and its corresponding generated Rsense pin voltage (the "Center Value").

Deet (O)	Rsense Voltage (mV)		
Rset (Ω)	Center Value		
976k	1875		
825k	1585		
698k	1341		
590k	1134		
499k	959		
412k	792		
340k	653		
280k	538		
226k	434		
178k	342		
140k	269		
105k	202		
75k	146		
46.4k	87		
22.6k	43		
0.01k	0		

Applications Circuits

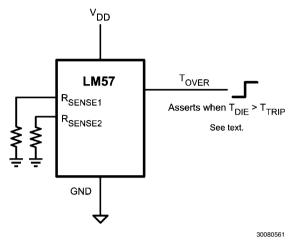


FIGURE 5. Temperature Switch Using Push-Pull Output

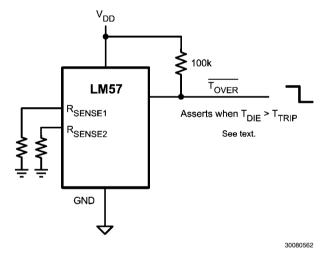
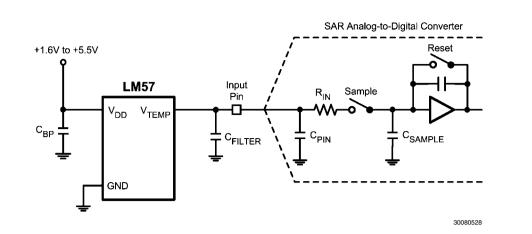


FIGURE 6. Temperature Switch Using Open-Drain Output

LM57



Most CMOS ADCs found in microcontrollers and ASICs have a sampled data comparator input structure. When the ADC charges the sampling cap, it requires instantaneous charge from the output of the analog source such as the LM57 temperature sensor and many op amps. This requirement is easily accommodated by the addition of a capacitor (C_{FILTER}). The size of C_{FILTER} depends on the size of the sampling capacitor and the sampling frequency. Since not all ADCs have identical input stages, the charge requirements will vary. This general ADC application is shown as an example only.



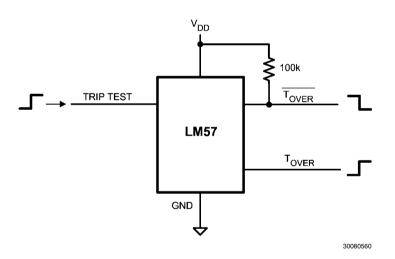
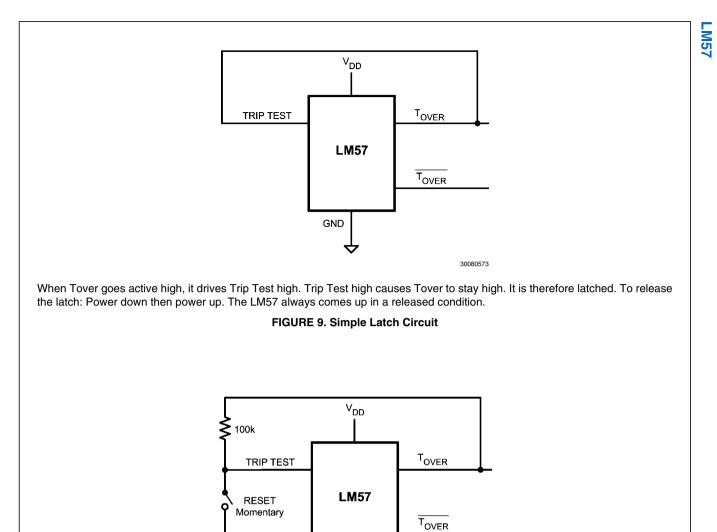


FIGURE 8. TRIP TEST Digital Output Test Circuit



The TRIP TEST pin, normally used to check the operation of the T_{OVER} and $\overline{T_{OVER}}$ pins, may be used to latch the outputs whenever the temperature exceeds the programmed limit and causes the digital outputs to assert. As shown in the figure, when T_{OVER} goes high the TRIP TEST input is also pulled high and causes T_{OVER} output to latch high and the $\overline{T_{OVER}}$ output to latch low. Momentarily switching the TRIP TEST input low will reset the LM57 to normal operation. The resistor limits the current out of the T_{OVER} output pin.

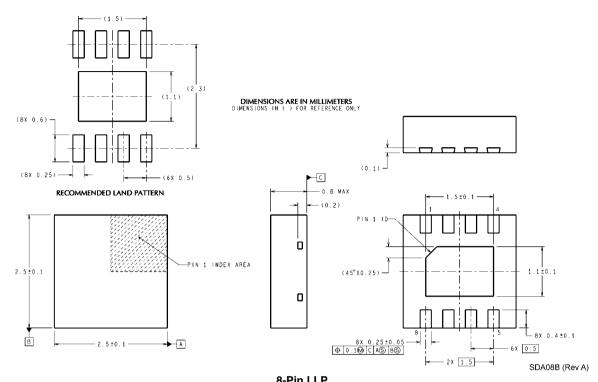
30080565

GND

FIGURE 10. Latch Circuit using T_{OVER} Output

Physical Dimensions inches (millimeters) unless otherwise noted

LM57



8-Pin LLP NS Package Number SDA08B

Notes

Notes

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LDOs	www.national.com/ldo	Quality and Reliability	www.national.com/quality
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Voltage References	www.national.com/vref	Design Made Easy	www.national.com/easy
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